Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/015,322	DANSIE ET AL.	
Examiner	Art Unit	
Sargon N. Nano	2157	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
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EAST (see attached report)	8/15/2005	SN